

# Origin of n-type conductivity of polycation compound $\text{Mg}_2\text{SnN}_2$ and polyanion compound $\text{Zn}_2\text{NBr}$ in wurtzite phase

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The wurtzite structure is a typical crystal structure of traditional semiconductors, such as GaN and ZnO. Polycation compounds  $\text{Zn-IV-N}_2$  (IV = Si, Ge, Sn) and  $\text{II-Sn-N}_2$  (II = Mg, Ca) are obtained on the basis of GaN via cation mutation [1]. Similarly, polyanion compounds  $\text{Zn}_2\text{NX}$  (X = Cl, Br, I) are derived from ZnO by anion mutation [2].  $\text{Zn-IV-N}_2$  (IV = Si, Ge, Sn) thin film have been synthesised, and proposed as photovoltaic absorbers [3]. However, among them,  $\text{ZnSnN}_2$  suffers from high carrier concentration which can change the onset of the light absorption spectrum due to the Burstein-Moss effect and exceed the optimal range of carrier concentrations for photovoltaic applications ( $10^{16}$ – $10^{18}$   $\text{cm}^{-3}$ ) [3-4]. In contrast to the intense research on  $\text{Zn-IV-N}_2$  (IV = Si, Ge, Sn), investigation on  $\text{II-Sn-N}_2$  (II = Mg, Ca) and  $\text{Zn}_2\text{NX}$  (X = Cl, Br, I) has only been started recently. Their properties, especially their potential as photovoltaic absorbers deserve further exploration due to their earth abundant composition. Here, we study the phase stability and defect properties of two representative compounds: the polycation  $\text{MgSnN}_2$  and polyanion  $\text{Zn}_2\text{NBr}$  in the wurtzite structure via first-principles calculations. We find that both  $\text{MgSnN}_2$  and  $\text{Zn}_2\text{NBr}$  show n-type conductivity but with different origins. The low-energy donor-type antisite defect,  $\text{Sn}_{\text{Mg}}$ , is the primary source of the high electron carrier concentration ( $10^{16}$   $\text{cm}^{-3}$  –  $10^{18}$   $\text{cm}^{-3}$ ), which leads to self-doped *n*-type conductivity in  $\text{MgSnN}_2$ . On the contrary, the compensation between the donor-type defect  $\text{V}_{\text{Br}}$  and acceptor-type  $\text{N}_{\text{Br}}$  pins the Fermi level close to the conduction band for the whole chemical potential range, resulting in intrinsic *n*-type conductivity in  $\text{Zn}_2\text{NBr}$  with a carrier density level around  $10^{15}$   $\text{cm}^{-3}$ . Our results would be useful for future study of adjusting electrical conductivity for poly-element wurtzite compounds.

[1] Punya, A., et.al., "Quasiparticle band structure of Zn-IV-N<sub>2</sub> compounds", Phys. Rev. B., 84. 165204. (2011).

[2] Liu, X., et.al., "Synthesis and single-crystal structure determination of the zinc nitride halides  $\text{Zn}_2\text{NX}$  (X= Cl, Br, I)", J. Solid State Chem., 203. 31-36. (2013).

[3] Lahourcade, L., et.al., "Structural and optoelectronic characterization of RF sputtered  $\text{ZnSnN}_2$ ", Adv. Mater., 25. 2562-2566. (2013).

[4] Tsunoda, N., et.al., "Electrically benign defect behavior in zinc tin nitride revealed from first principles", Phys. Rev. Appl., 10. 011001. (2018).